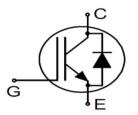


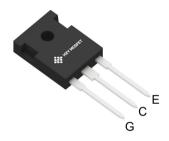
Features

- 650V, 100A IGBT
- High Input Impedance
- Low Saturation Voltage V_{CE(SAT)}
- Low Switching Losses
- Low Conduction for a High Efficiency
- Rugged Transient Reliability
- Low EMI

Application

- Industrial UPS
- EV-Charging
- String inverter
- Welding





Key Performance and Package Parameters

Device	V _{CE}	I _C (T _c = 25 °C)	V _{CE(SAT)} (T _{VJ} = 25 °C, V _{GE} = 15 V)	Tvjmax	Package
STGWA100H65DFB2	650V	100A	1.45	175°C	TO-247

Absolute Maximum Ratings

Symbol	Parameter		Value	Units
V _{CE}	Collector emitter voltage	T _{VJ} = 25°C	650	V
	DC collector comment limited by Tribony	T _C = 25°C	150	А
I _C	DC collector current,limited by Tvjmax	T _C = 100°C	100	А
I _{Cpuls}	Pulsed collector current,limited by Tvjmax		300	А
I _F	Maximum Diode forward current, limited by Tvjmax	T _C = 25°C	150	А
		T _C = 100°C	100	А
I _{Fpuls}	Diode pulsed current, limited by Tvjmax		300	А
V_{GE}	Gate-Emitter voltage	T _{VJ} = 25°C	±20	V
Б		T _C = 25°C	429	W
P_{tot}	Power Dissipation	T _C = 100°C	214	W
T _{VJ}	Operating Junction Temperature Range		-55 to +175	°C
T _{STG}	Storage Temperature Range		-55 to +175	°C
T_{vjOP}	Temperature under switching condition	ns	-40 to +150	°C

STGWA100H65DFB2

Insulated Gate Bipolar Transistor

Thermal Resistance

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
R_{thJC}	IGBT Thermal resistance: junction - case	IGBT	-	0.25	0.35	°C/W
R_{thJC}	Diode Thermal resistance: junction - case	Diode	-	0.28	0.38	°C/W

Static Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
V _{(BR)CES}	Collector - Emitter Breakdown Voltage	$V_{GE} = 0V$, $I_C = 1mA$, $T_{VJ} = 25^{\circ}C$	650	-	-	V
W	Collector - Emitter Saturation Voltage	V _{GE} = 15V , I _C = 100A ,T _{VJ} = 25°C	-	1.45	-	V
V _{CESAT}		$V_{GE} = 15V$, $I_{C} = 100A$, $T_{VJ} = 175^{\circ}C$	-	1.75	-	V
V	Diode forward voltage	V _{GE} = 0V , I _C = 100A ,T _{VJ} = 25°C	-	1.55	-	V
V_{F}		$V_{GE} = 0V$, $I_{C} = 100A$, $T_{VJ} = 175^{\circ}C$	-	1.6	-	V
V _{GE(th)}	Gate-Emitter threshold voltage	$V_{GE} = V_{CE}, I_{C} = 0.88 \text{mA}, T_{VJ} = 25^{\circ}\text{C}$	-	4	-	V
I _{CES}	Zero Gate voltage Collector current	$V_{CE} = 650V$, $V_{GE} = 0V$, $T_{VJ} = 25^{\circ}C$	-	-	100	μА
	0.1.5 % 1.1.	V _{GE} = 20V , V _{CE} = 0V	-	-	100	nA
I _{GES}	Gate-Emitter leakage current	V_{GE} = -20V, V_{CE} = 0V	-100	-	-	nA

Dynamic Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
C _{ies}	Input Capacitance		-	3452	-	pF
C _{oes}	Output Capacitance	$V_{GE} = 0V, V_{CE} = 25V,$ f = 100K Hz	-	223	-	pF
C _{res}	Reverse Transfer Capacitance		-	26	-	pF
Q_g	Gate Charge	$V_{GE} = 0 \text{ to } 15V$ $V_{CE} = 520V, I_{C} = 100A$	-	156	-	nC

Switching Characteristics

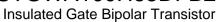
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-On DelayTime		-	27	-	ns
t _r	Turn-On Rise Time	T - 25 °C	-	58	-	ns
t _{d(off)}	Turn-Off DelayTime	T _{vj} = 25 °C, V _{CE} = 400 V,	-	195	-	ns
t _f	Turn-Off Fall Time	I _C = 100 A,	-	66	-	ns
E _{on}	Turn-on energy	$V_{GE} = 0 / 15 V$,	-	3.3	-	mJ
E _{off}	Turn-off energy	$R_{G(on)} = 10 \Omega, R_{G(off)} = 10 \Omega$	-	1.65	-	mJ
E _{ts}	Total switching energy		-	4.35	-	mJ
t _{d(on)}	Turn-On DelayTime		-	27	-	ns
t _r	Turn-On Rise Time	T - 175 °C	-	50	-	ns
t _{d(off)}	Turn-Off DelayTime	T _{vj} = 175 °C, V _{CE} = 400 V,	-	215	-	ns
t _f	Turn-Off Fall Time	I _C = 100 A,	-	58	-	ns
E _{on}	Turn-on energy	$V_{GE} = 0 / 15 V,$ $R_{G(on)} = 10 \Omega, R_{G(off)} = 10 \Omega$	-	3.77	-	mJ
E _{off}	Turn-off energy		-	2.07	-	mJ
E _{ts}	Total switching energy		-	5.84	-	mJ

STGWA100H65DFB2

Insulated Gate Bipolar Transistor

Diode Recovery Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
T _{rr}	Reverse recovery time	T _{vi} = 25 °C	-	123	-	ns
Q_{rr}	Reverse recovery charge	$V_{CE} = 400 \text{ V}, I_{C} = 100 \text{ A}$	-	1.95	-	μС
I _{rrm}	Peak reverse recovery current	$V_{GE} = 0 / 15 V$ $R_{G(on)} = 10 \Omega, R_{G(off)} = 10 \Omega$	-	30.8	-	Α
E _{rec}	Reverse recovery energy		-	0.47	-	mJ
T _{rr}	Reverse recovery time	T _{vi} = 175 °C	-	150	-	ns
Q_{rr}	Reverse recovery charge	$V_{CE} = 400 \text{ V}, I_{C} = 100 \text{ A}$ $V_{GE} = 0 / 15 \text{ V}$	-	3.85	-	μС
I _{rrm}	Peak reverse recovery current		-	44.1	-	Α
E _{rec}	Reverse recovery energy	$R_{G(on)} = 10 \Omega, R_{G(off)} = 10 \Omega$	-	0.98	-	mJ





Typical Performance Characteristics

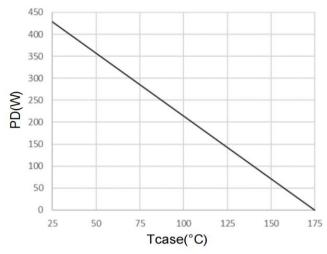


Figure 1:Power De-rating

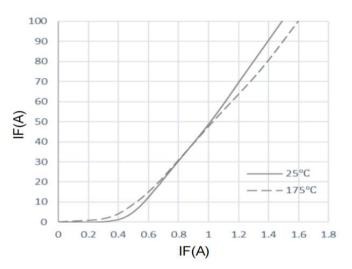


Figure 3:Diode Forward current characteristics

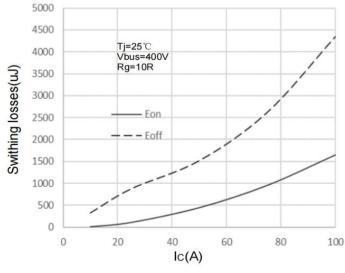


Figure 5:Switching losses(uJ)

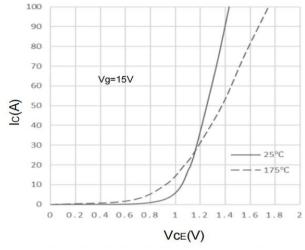


Figure 2:Typical Output characteristics

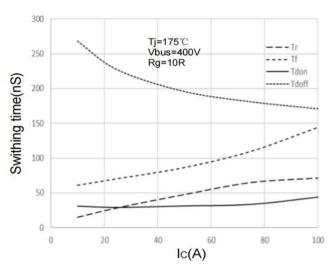


Figure 4:Switching time(nS)

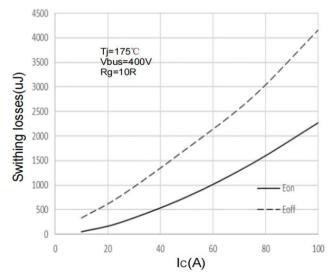


Figure 6:Switching losses(uJ)

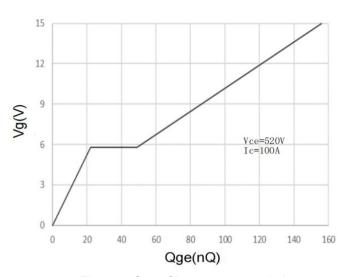


Figure 7: Gate-Charge characteristics

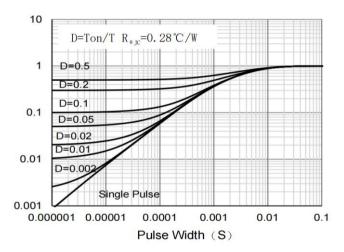


Figure 9:Normalized Maximum Diode transient thermal impedance

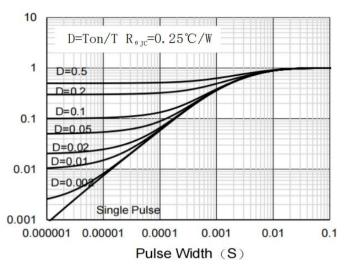
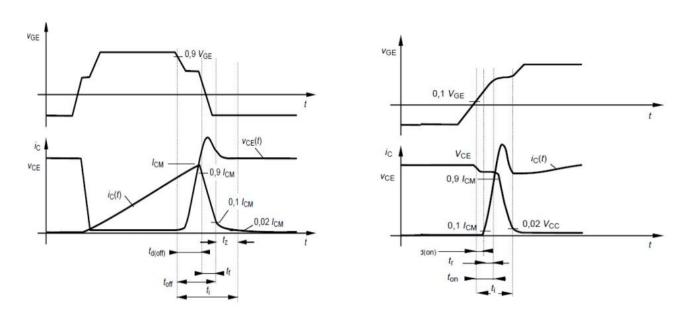


Figure 8:Normalized Maximum IGBT transient thermal impedance

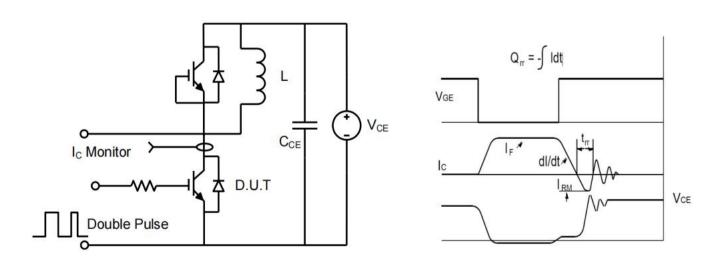


Test Circuit

Switching Test Circuit & Waveforms

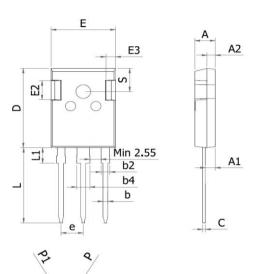


Diode Recovery Test Circuit & Waveforms





Package Mechanical Data(TO-247)



D1



SYMBOL	mm				
STWIDOL	MIN	NOM	MAX		
A	4.80	5.00	5.20		
A1	2.21	2.41	2.56		
A2	1.85	2.00	2.15		
b	1.10	1.20	1.35		
b2	1.90	2.10	2.20		
b4	2.90	3.10	3.20		
С	0.50	0.60	0.75		
D	20.70	21.00	21.30		
D1	16.25	16.55	16.85		
Е	15.50	15.80	16.10		
E1	13.00	13.30	13.60		
E2	4.80	5.00	5.20		
E3	2.30	2.50	2.70		
e		5.44BSC	5		
L	19.72	19.92	20.12		
L1	-	-	4.30		
ØP1	3.40	3.60	3.80		
ØΡ	3 4 3	-7	7.30		
S		6.15BSC	•		



Attention

- Any and all HUA XUAN YANG ELECTRONICS products described or contained herein do not have specifications that can handle applications that require extremely high levels of reliability, such as life-support systems, aircraft's control systems, or other applications whose failure can be reasonably expected to result in serious physical and/or material damage. Consult with your HUA XUAN YANG ELECTRONICS representative nearest you before using any HUA XUAN YANG ELECTRONICS products described or contained herein in such applications.
- HUA XUAN YANG ELECTRONICS assumes no responsibility for equipment failures that result from using products at values that exceed, even momentarily, rated values (such as maximum ratings, operating condition ranges, or other parameters) listed in products specifications of any and all HUA XUAN YANG ELECTRONICS products described or contained herein.
- Specifications of any and all HUA XUAN YANG ELECTRONICS products described or contained herein stipulate the performance, characteristics, and functions of the described products in the independent state, and are not guarantees of the performance, characteristics, and functions of the described products as mounted in the customer's products or equipment. To verify symptoms and states that cannot be evaluated in an independent device, the customer should always evaluate and test devices mounted in the customer's products or equipment.
- HUA XUAN YANG ELECTRONICS CO.,LTD. strives to supply high-quality high-reliability products. However, any and all semiconductor products fail with some probability. It is possible that these probabilistic failures could give rise to accidents or events that could endanger human lives, that could give rise to smoke or fire, or that could cause damage to other property. When designing equipment, adopt safety measures so that these kinds of accidents or events cannot occur. Such measures include but are not limited to protective circuits and error prevention circuits for safe design, redundant design, and structural design.
- In the event that any or all HUA XUAN YANG ELECTRONICS products(including technical data, services) described or contained herein are controlled under any of applicable local export control laws and regulations, such products must not be exported without obtaining the export license from the authorities concerned in accordance with the above law.
- No part of this publication may be reproduced or transmitted in any form or by any means, electronic or mechanical, including photocopying and recording, or any information storage or retrieval system, or otherwise, without the prior written permission of HUA XUAN YANG ELECTRONICS CO.,LTD.
- Information (including circuit diagrams and circuit parameters) herein is for example only; it is not guaranteed for volume production. HUA XUAN YANG ELECTRONICS believes information herein is accurate and reliable, but no guarantees are made or implied regarding its use or any infringements of intellectual property rights or other rights of third parties.
- Any and all information described or contained herein are subject to change without notice due to product/technology improvement, etc. When designing equipment, refer to the "Delivery Specification" for the HUA XUAN YANG ELECTRONICS product that you intend to use.